## Notice of References Cited Application/Control No. 10/797,135 Examiner Keith Hendricks Applicant(s)/Patent Under Reexamination TAKEBE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,042,851 A	03-2000	Matsuura et al.	426/8
*	В	US-6,284,304 B1	09-2001	Matsuura et al.	426/634
*	С	US-6,342,256 B1	01-2002	Oomura et al.	426/46
*	D	US-5,965,176 A	10-1999	Yamamoto, Yoshihisa	426/46
*	Ε	US-6,582,739 B1	06-2003	Sawano et al.	426/46
*	F	US-5,055,310	10-1991	Nonaka et al.	426/46
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			·
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	58-028234	02-1983	JP	Chiba et al.	A23J 3/00
	0					
	Р			·		:
	Q					
	R					
	s		,			
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.